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March 2015

# FGH20N60UFD 600 V, 20 A Field Stop IGBT

#### **Features**

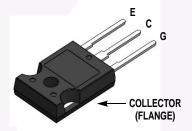
- · High Current Capability
- Low Saturation Voltage: V<sub>CE(sat)</sub> =1.8 V @ I<sub>C</sub> = 20 A
- High Input Impedance
- Fast Switching
- RoHS Compliant

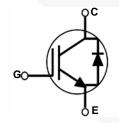
#### **Applications**

• Solar Inverter, UPS, Welder, PFC

### **General Description**

Using novel field stop IGBT technology, Fairchild's field stop IGBTs offer the optimum performance for solar inverter, UPS, welder and PFC applications where low conduction and switching losses are essential.





### **Absolute Maximum Ratings**

| Symbol              | Description   | n                       | Ratings     | Unit |
|---------------------|---|-------------------------|-------------|------|
| V <sub>CES</sub>    | Collector to Emitter Voltage  |                         | 600         | V    |
| V                   | Gate to Emitter Voltage   |                         | ±20         | V    |
| $V_{GES}$           | Transient Gate-to-Emitter Voltage                                     |                         | ±30         | V    |
| I <sub>C</sub>      | Collector Current   | @ T <sub>C</sub> = 25°C | 40          | A    |
| iC                  | Collector Current   | $@ T_C = 100^{\circ}C$  | 20          | A    |
| I <sub>CM (1)</sub> | Pulsed Collector Current  | @ T <sub>C</sub> = 25°C | 60          | Α    |
| L                   | Diode Forward Current   | $@ T_C = 25^{\circ}C$   | 20          | A    |
| IF                  | Diode Forward Current @ T <sub>C</sub> = 100°C                        |                         | 10          | A    |
| I <sub>FM (1)</sub> | Pulsed Diode Maximum Forward C  | urrent                  | 60          | A    |
| P <sub>D</sub>      | Maximum Power Dissipation   | @ T <sub>C</sub> = 25°C | 165         | W    |
| . р                 | Maximum Power Dissipation   | $@ T_C = 100^{\circ}C$  | 66          | W    |
| $T_J$               | Operating Junction Temperature  |                         | -55 to +150 | °C   |
| T <sub>stg</sub>    | Storage Temperature Range   |                         | -55 to +150 | °C   |
| TL                  | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 secon | nds                     | 300         | °C   |

#### Notes

1: Repetitive rating: Pulse width limited by max. junction temperature

## **Package Marking and Ordering Information**

| Part Number   | Top Mark    | Package | Packing Method | Reel Size | Tape Width | Quantity |
|---------------|-------------|---------|----------------|-----------|------------|----------|
| FGH20N60UFDTU | FGH20N60UFD | TO-247  | Tube           | N/A       | N/A        | 30       |

## Electrical Characteristics of the IGBT $T_C = 25$ °C unless otherwise noted

| Symbol                           | Parameter                                    | Test Conditions   | Min. | Тур. | Max. | Unit |
|----------------------------------|--|---|------|------|------|------|
| Off Charac                       | teristics                                    |   |      | *    | •    |      |
| BV <sub>CES</sub>                | Collector to Emitter Breakdown Voltage       | $V_{GE} = 0 \text{ V}, I_{C} = 250 \mu\text{A}$                             | 600  | -    | -    | V    |
| $\Delta BV_{CES}$ / $\Delta T_J$ | Temperature Coefficient of Breakdown Voltage | $V_{GE} = 0 \text{ V, } I_{C} = 250 \mu\text{A}$                            | -    | 0.6  | -    | V/°C |
| I <sub>CES</sub>                 | Collector Cut-Off Current                    | $V_{CE} = V_{CES}, V_{GE} = 0 V$  | -    | -    | 250  | μΑ   |
| I <sub>GES</sub>                 | G-E Leakage Current                          | $V_{GE} = V_{GES}, V_{CE} = 0 V$  | -    | -    | ±400 | nA   |
| On Charac                        | teristics                                    |   |      |      |      |      |
| V <sub>GE(th)</sub>              | G-E Threshold Voltage                        | $I_C = 250 \mu A, V_{CE} = V_{GE}$  | 4.0  | 5.0  | 6.5  | V    |
|                                  |  | I <sub>C</sub> = 20 A, V <sub>GE</sub> = 15 V                               | -    | 1.8  | 2.4  | V    |
| V <sub>CE(sat)</sub>             | Collector to Emitter Saturation Voltage      | $I_C = 20 \text{ A, V}_{GE} = 15 \text{ V,}$<br>$T_C = 125^{\circ}\text{C}$ | -    | 2.0  | -    | V    |
| Dynamic C                        | haracteristics                               |   |      |      |      |      |
| C <sub>ies</sub>                 | Input Capacitance                            |   | -    | 940  | -    | pF   |
| C <sub>oes</sub>                 | Output Capacitance                           | $V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$<br>f = 1  MHz                | -    | 110  | -    | pF   |
| C <sub>res</sub>                 | Reverse Transfer Capacitance                 | 1 - 1 1/11/12   | -    | 40   | -    | pF   |
| Switching                        | Characteristics                              |   |      |      |      |      |
| t <sub>d(on)</sub>               | Turn-On Delay Time                           |   | -    | 13   | -    | ns   |
| t <sub>r</sub>                   | Rise Time                                    |   | -    | 17   | -    | ns   |
| t <sub>d(off)</sub>              | Turn-Off Delay Time                          | $V_{CC} = 400 \text{ V}, I_{C} = 20 \text{ A},$                             | -    | 87   | -    | ns   |
| t <sub>f</sub>                   | Fall Time                                    | $R_G = 10 \Omega$ , $V_{GE} = 15 V$ ,                                       | -    | 32   | 64   | ns   |
| E <sub>on</sub>                  | Turn-On Switching Loss                       | Inductive Load, T <sub>C</sub> = 25°C                                       | -    | 0.38 | -    | mJ   |
| E <sub>off</sub>                 | Turn-Off Switching Loss                      |   | - /  | 0.26 | -    | mJ   |
| E <sub>ts</sub>                  | Total Switching Loss                         |   | -    | 0.64 | -    | mJ   |
| t <sub>d(on)</sub>               | Turn-On Delay Time                           |   | -    | 13   | - /  | ns   |
| t <sub>r</sub>                   | Rise Time                                    |   | -    | 16   | - 🗸  | ns   |
| t <sub>d(off)</sub>              | Turn-Off Delay Time                          | $V_{CC} = 400 \text{ V}, I_{C} = 20 \text{ A},$                             | -    | 92   | -    | ns   |
| t <sub>f</sub>                   | Fall Time                                    | $R_G = 10 \Omega$ , $V_{GE} = 15 V$ , Inductive Load, $T_C = 125^{\circ}C$  | -    | 63   | / -  | ns   |
| E <sub>on</sub>                  | Turn-On Switching Loss                       |   | -    | 0.41 | - /  | mJ   |
| E <sub>off</sub>                 | Turn-Off Switching Loss                      |   | -    | 0.36 | -    | mJ   |
| E <sub>ts</sub>                  | Total Switching Loss                         |   | -    | 0.77 | - \  | mJ   |
| Qg                               | Total Gate Charge                            |   | -    | 63   | -    | nC   |
| Q <sub>ge</sub>                  | Gate to Emitter Charge                       | $V_{CE} = 400 \text{ V}, I_{C} = 20 \text{ A},$<br>$V_{GE} = 15 \text{ V}$  | -    | 7    | -    | nC   |
| Q <sub>gc</sub>                  | Gate to Collector Charge                     | VGE = 10 V  | -    | 32   | -    | nC   |

### **Thermal Characteristics**

| Symbol                 | Parameter                               | Тур. | Max. | Unit |
|------------------------|---|------|------|------|
| $R_{\theta JC}(IGBT)$  | Thermal Resistance, Junction to Case    | -    | 0.76 | °C/W |
| $R_{\theta JC}(Diode)$ | Thermal Resistance, Junction to Case    | -    | 2.51 | °C/W |
| $R_{\theta JA}$        | Thermal Resistance, Junction to Ambient | -    | 40   | °C/W |

# Electrical Characteristics of the Diode $T_C = 25^{\circ}C$ unless otherwise noted

| Symbol          | Parameter                     |  | Test Conditions                 |                                  | Min. | Тур. | Max | Unit |
|-----------------|-------------------------------|--|---------------------------------|----------------------------------|------|------|-----|------|
| V <sub>FM</sub> | Diode Forward Voltage         | I <sub>F</sub> = 10                                  | 10 A                            | $T_{\rm C} = 25^{\rm o}{\rm C}$  | -    | 1.9  | 2.5 | V    |
|                 |                               |  |                                 | $T_{\rm C} = 125^{\rm o}{\rm C}$ | -    | 1.7  | -   | ,    |
| t <sub>rr</sub> | Diode Reverse Recovery Time   | I <sub>E</sub> =10 A, di <sub>E</sub> /dt = 200 A/μs | $T_{\rm C} = 25^{\rm o}{\rm C}$ | -                                | 34   | -    | ns  |      |
|                 |                               |  | 10 A di_/dt = 200 A/us          | $T_{\rm C} = 125^{\rm o}{\rm C}$ | -    | 57   | -   |      |
| Q <sub>rr</sub> | Diode Reverse Recovery Charge | 'F =   | 10 / ι, αιμ/αι = 200 / υμο      | $T_C = 25^{\circ}C$              | -    | 41   | -   | nC   |
|                 |                               |  |                                 | $T_{\rm C} = 125^{\rm o}{\rm C}$ | -    | 96   | -   |      |

Figure 1. Typical Output Characteristics

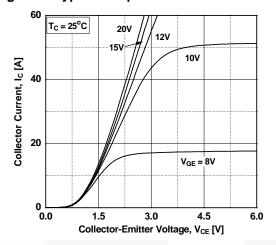


Figure 3. Typical Saturation Voltage Characteristics

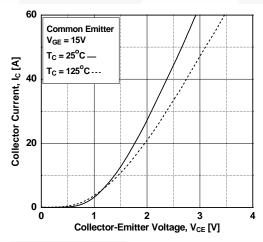
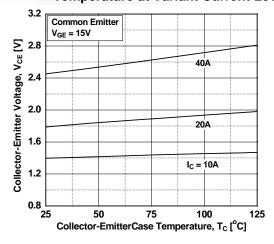


Figure 5. Saturation Voltage vs. Case
Temperature at Variant Current Level



**Figure 2. Typical Output Characteristics** 

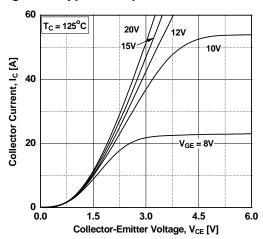


Figure 4. Transfer Characteristics

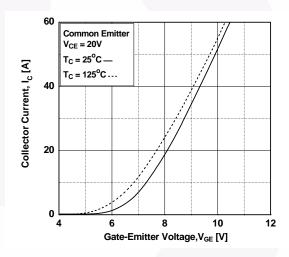


Figure 6. Saturation Voltage vs. V<sub>GE</sub>

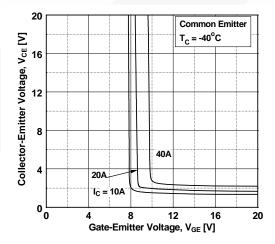


Figure 7. Saturation Voltage vs. V<sub>GE</sub>

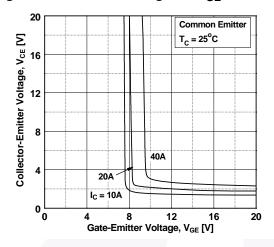


Figure 9. Capacitance Characteristics

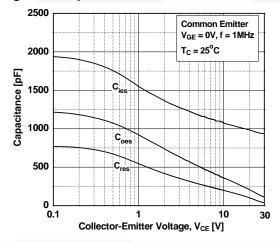


Figure 11. SOA Characteristics

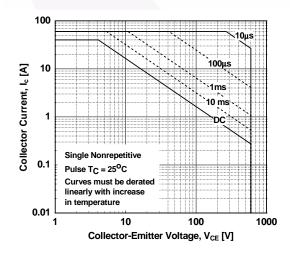


Figure 8. Saturation Voltage vs. V<sub>GE</sub>

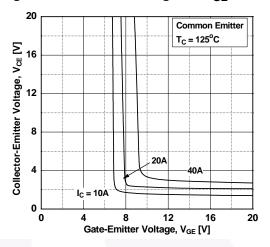


Figure 10. Gate charge Characteristics

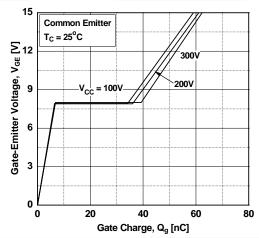


Figure 12. Turn-on Characteristics vs.
Gate Resistance

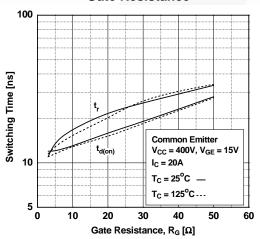


Figure 13. Turn-off Characteristics vs.
Gate Resistance

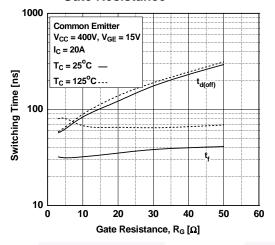


Figure 14. Turn-on Characteristics vs.
Collector Current

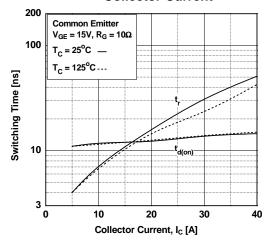


Figure 15. Turn-off Characteristics vs. Collector Current

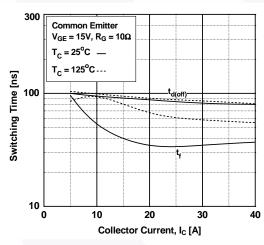


Figure 16. Switching Loss vs.
Gate Resistance

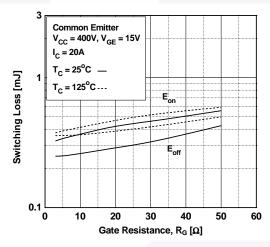


Figure 17. Switching Loss vs. Collector Current

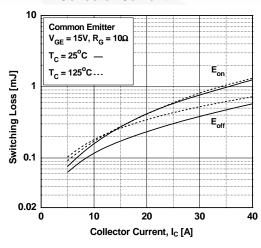


Figure 18. Turn off Switching SOA Characteristics

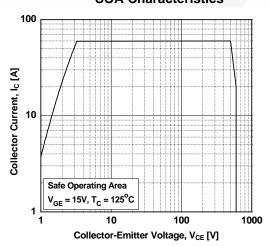


Figure 19. Forward Characteristics

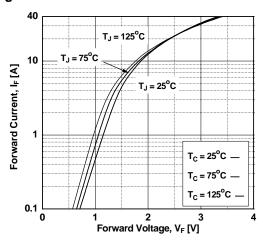


Figure 20. Reverse Current

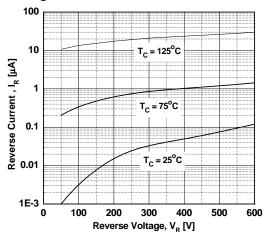


Figure 21. Stored Charge

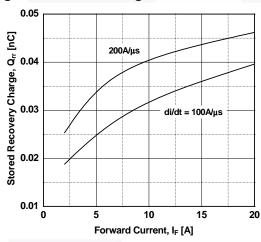


Figure 22. Reverse Recovery Time

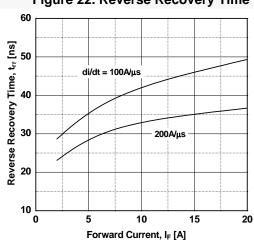
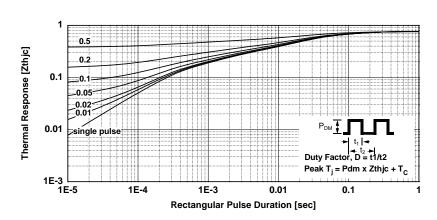
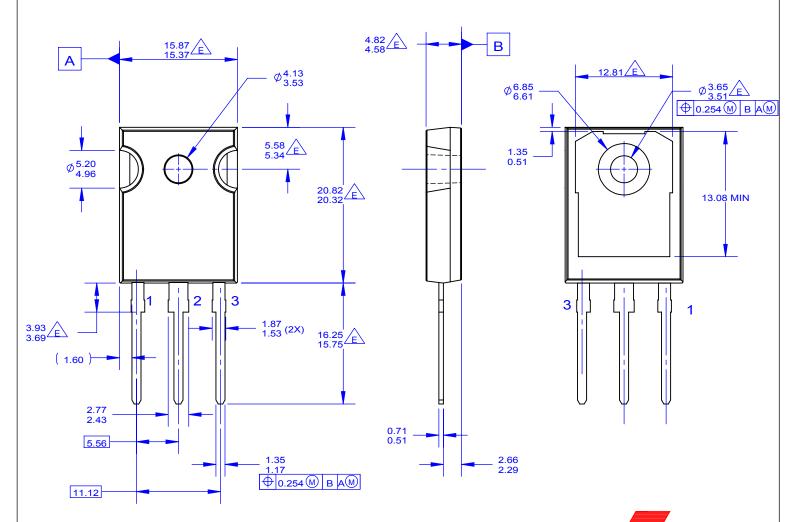


Figure 23. Transient Thermal Impedance of IGBT







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